MSKSEMI 美森科













ESD

/S

TSS

MOV

GDT

PLED

AO3406

Product specification





Features

- 30V,3.5A , RDS(ON)=35mΩ@VGS=10V
- Improved dv/dt capability
- Fast switching
- Green Device Available

Applications

- MB / VGA / Vcore
- Load Switch
- Hand-Held Instrument

BVDSS	RDSON	ID
30V	35mΩ	3.5A

Reference News

PACKAGE OUTLINE	PIN Configuration	Marking
SOT-23-3L	G	A6 ** ×

Absolute Maximum Ratings Tc=25℃ unless otherwise noted

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	30	V
Vgs	Gate-Source Voltage	±20	V
lo	Drain Current - Continuous (T _A =25°C)	3.5	А
ID.	Drain Current - Continuous (T _A =70°C)	1.68	А
Ірм	Drain Current - Pulsed ¹	14	Α
D-	Power Dissipation (T _A =25°C)	278	mW
PD	Power Dissipation - Derate above 25°C	2.22	mW/°C
Тѕтс	Storage Temperature Range	-50 to 150	°C
TJ	Operating Junction Temperature Range	-50 to 150	°C

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Unit
R _{eJA} Thermal Resistance Junction to ambient			450	°C/W



Electrical Characteristics (TJ=25 ℃, unless otherwise noted)

Off Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _G s=0V , I _D =250uA	30			V
△BVbss/△TJ	BV _{DSS} Temperature Coefficient	Reference to 25℃, I _D =1mA		0.018		V/°C
	Drain Source Leakage Current	V _{DS} =30V , V _{GS} =0V , T _J =25℃			1	uA
IDSS	Drain-Source Leakage Current	V _{DS} =24V , V _{GS} =0V , T _J =125℃			10	uA
Igss	Gate-Source Leakage Current	Vgs=±20V , Vps=0V			±100	nA

On Characteristics

RDS(ON)	Static Drain-Source On-Resistance	V _G s=10V , I _D =3.5A		35	50	mΩ
T CDS(ON)	Static Dialii-Source Off-Nesistance	Vgs=4.5V , ID=2.5A		45	70	mΩ
V _G S(th)	Gate Threshold Voltage	-Vgs=Vds , Id =250uA	1	1.5	2.5	V
$\triangle V$ GS(th)	V _{GS(th)} Temperature Coefficient	7 VG5- VD5 , ID -230UA		-3.2		mV/℃
gfs	Forward Transconductance	V _{DS} =10V , I _D =2A		2.3		S

Dynamic and switching Characteristics

Qg	Total Gate Charge ^{2,3}		I	3.1	I	
Qgs	Gate-Source Charge ^{2,3}	V _{DS} =24V , V _{GS} =10V , I _D =1A	-	0.1	-	nC
Qgd	Gate-Drain Charge ^{2, 3}			1.7		
Td(on)	Turn-On Delay Time ^{2,3}		ŀ	2.2	I	
Tr	Rise Time ² , ³	V _{DD} =24V , V _{GS} =10V ,		6.9		
Td(off)	Turn-Off Delay Time ^{2, 3}	R _G =3.3Ω l _D =1A	-	15.2		ns
Tf	Fall Time ^{2, 3}		-	4.5	-	
Ciss	Input Capacitance			245		
Coss	Output Capacitance	VDS=25V , VGS=0V , F=1MHz		40		pF
Crss	Reverse Transfer Capacitance			78		

Drain-Source Diode Characteristics and Maximum Ratings

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
IS	Continuous Source Current	VG=VD=0V,Force Current			3.5	Α
ISM	Pulsed Source Current	TO TO ST , I dide current			7.0	Α
VSD	Diode Forward Voltage	VGS=0V,IS=1A,TJ=25℃			1.3	٧

Note:

- 1. Repetitive Rating: Pulsed width limited by maximum junction temperature.
- 2. The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%.
- 3. Essentially independent of operating temperature.



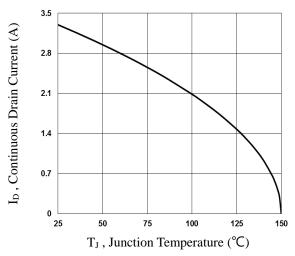


Fig.1 Continuous Drain Current vs. TJ

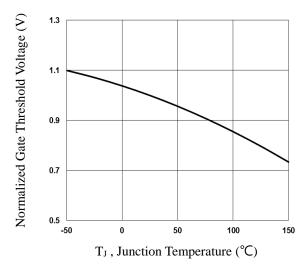


Fig.3 Normalized V_{th} vs. T_J

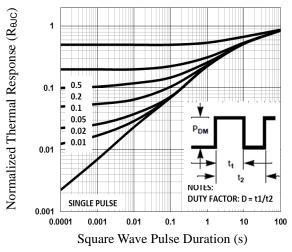


Fig.5 Normalized Transient Impedance

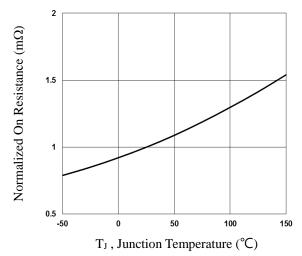


Fig.2 Normalized RDSON vs. TJ

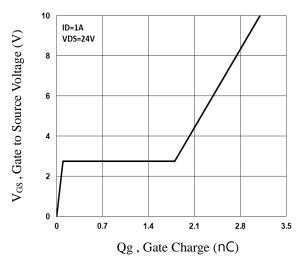


Fig.4 Gate Charge Waveform

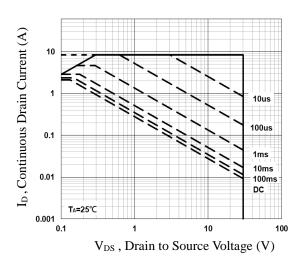
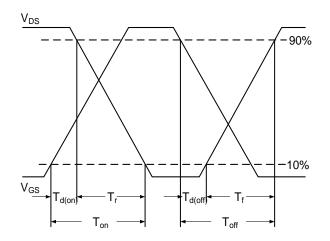


Fig.6 Maximum Safe Operation Area



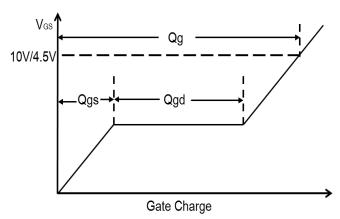
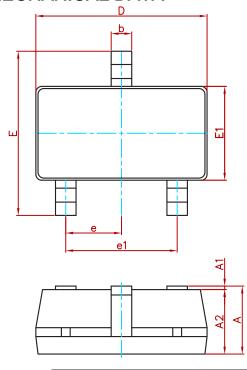


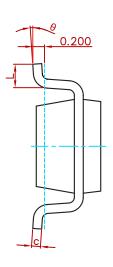
Fig.7 Switching Time Waveform

Fig.8 Gate Charge Waveform



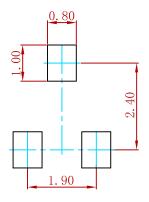
PACKAGE MECHANICAL DATA





Symbol	Dimensions In Millimeters		Dimension	s In Inches
Symbol	Min.	Max.	Min.	Max.
Α	1.050	1.250	0.041	0.049
A1	0.000	0.100	0.000	0.004
A2	1.050	1.150	0.041	0.045
b	0.300	0.500	0.012	0.020
С	0.100	0.200	0.004	0.008
D	2.820	3.020	0.111	0.119
E1	1.500	1.700	0.059	0.067
E	2.650	2.950	0.104	0.116
е	0.950(BSC)		0.037	(BSC)
e1	1.800	2.000	0.071	0.079
L	0.300	0.600	0.012	0.024
А	٥°	۵°	٥°	۵°

Suugested Pad Layout



Note:

- 1. Controlling dimension: in millimeters.
- 2.General tolerance:± 0.05mm.
- 3. The pad layout is for reference purposes only.

REELSPECIFICATION

P/N	PKG	QTY
AO3406	SOT-23-3L	3000



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